

A08806

Common-Drain Dual N-Channel Enhancement Mode Field Effect Transistor



General Description

The AO8806 uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V. This device is suitable for use as a load switch or in PWM applications. It is ESD protected. Standard Product AO8806 is Pb-free (meets ROHS & Sony 259 specifications).

Features

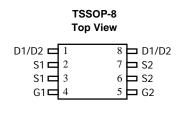
 $V_{DS}(V) = 20V$

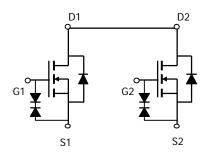
 $I_D = 7 A (V_{GS} = 4.5V)$

 $R_{DS(ON)}$ < 22m Ω (V_{GS} = 4.5V)

 $R_{DS(ON)}$ < 27m Ω (V_{GS} = 2.5V)

 $R_{DS(ON)}$ < 35m Ω (V_{GS} = 1.8V)





Absolute Maximum Ratings T _A =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		V_{DS}	20	V				
Gate-Source Voltage		V_{GS}	±8	V				
Continuous Drain	T _A =25°C		7					
Current ^A	T _A =70°C	I_D	5.7	Α				
Pulsed Drain Current ^B		I _{DM}	30					
	T _A =25°C	P_{D}	1.5	W				
Power Dissipation A	T _A =70°C		1	VV				
Junction and Storage Temperature Range		T_J , T_{STG}	-55 to 150	°C				

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{ heta JA}$	64	83	°C/W			
Maximum Junction-to-Ambient ^A	Steady-State	κ_{θ} JA	89	120	°C/W			
Maximum Junction-to-Lead ^C	Steady-State	$R_{ heta JL}$	53	70	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC I	PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		20			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =16V, V _{GS} =0V				1	
			T _J =55°C			5	μА
I_{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±4.5V				±1	μА
		V_{DS} =0V, V_{GS} =±8V				±10	μА
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		0.4	0.6	1	V
I _{D(ON)}	On state drain current	V _{GS} =4.5V, V _{DS} =5V		30			Α
R _{DS(ON)}		V _{GS} =4.5V, I _D =7A			16.5	22	mΩ
	Static Drain Source On Registance		T _J =125°C		23	29	
	Static Drain-Source On-Resistance	V _{GS} =2.5V, I _D =5.5A			20	27	mΩ
		V _{GS} =1.8V, I _D =5A			24	35	mΩ
9 _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =7A			29		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.76	1	V
I _S Maximum Body-Diode Continuous Current						2.5	Α
	CPARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =10V, f=1MHz			1160		pF
C _{oss}	Output Capacitance				187		pF
C _{rss}	Reverse Transfer Capacitance				146		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			1.5		Ω
SWITCHI	NG PARAMETERS		•				•
Q_g	Total Gate Charge	V _{GS} =4.5V, V _{DS} =10V, I _D =7A			16		nC
Q_{gs}	Gate Source Charge				8.0		nC
Q_{gd}	Gate Drain Charge				3.8		nC
t _{D(on)}	Turn-On DelayTime	V_{GS} =5V, V_{DS} =10V, R_L =1.35 Ω , R_{GEN} =3 Ω			6.2		ns
t _r	Turn-On Rise Time				12.7		ns
t _{D(off)}	Turn-Off DelayTime				51.7		ns
t _f	Turn-Off Fall Time				16		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =7A, dI/dt=100A/μs			17.7		ns
Q _{rr}	Body Diode Reverse Recovery Charge	e I _F =7A, dl/dt=100A/μs			6.7		nC

A: The value of $R_{\theta,JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t \le 10s thermal resistance rating.

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B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using <300 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25 °C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

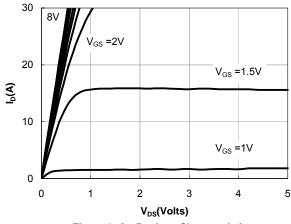


Figure 1: On-Regions Characteristi CS

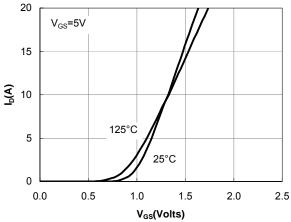


Figure 2: Transfer Characteristics

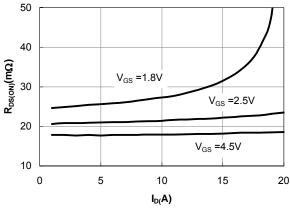


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

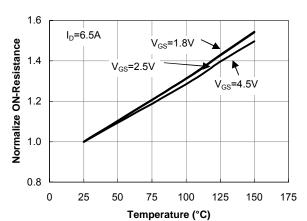


Figure 4: On-Resistance vs. Junction Temperature

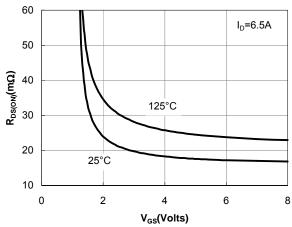


Figure 5: On-Resistance vs. Gate-Source Voltage

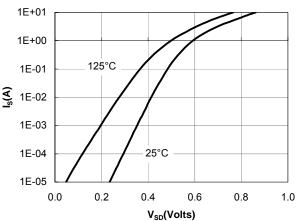


Figure 6: Body-Diode Characteristics

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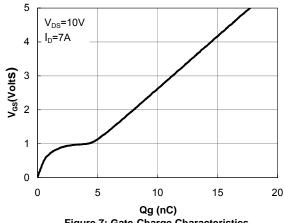


Figure 7: Gate-Charge Characteristics

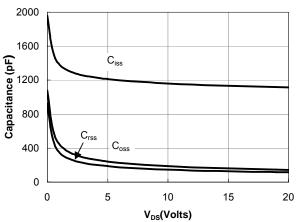


Figure 8: Capacitance Characteristics

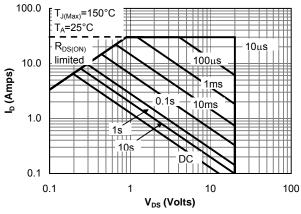


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

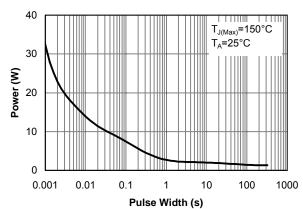


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

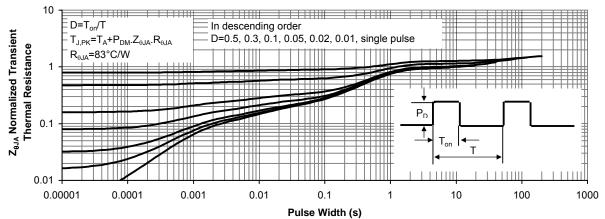


Figure 11: Normalized Maximum Transient Thermal Impedance